

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components,
Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 23.0001
CB Certificate No.: 50600525 ITL

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Appendix-1 (50600525 ITL) Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
Direct Current Supply Voltage	ISO 16750-2-4.2
Generator Overvoltage	ISO 16750-2-4.3.1.1
Slow decrease and increase of supply voltage	ISO 16750-2-4.5
Reset behavior at voltage drop	ISO 16750-2-4.6.2
Insulation Resistance test	ISO 16750-2-4.12
Damp heat cyclic test	ISO 16750-4-5.6.2.2 test 1
High temperature storage Test	ISO 16750-4-5.1.2 IEC 60068-2-2
High temperature Operation test	ISO 16750-4-5.1.2 IEC 60068-2-2
Low temperature Storage Test	ISO 16750-4-5.1.1 IEC 60068-2-1
Low temperature Operation test	ISO 16750-4-5.1.1 IEC 60068-2-1
Temperature cycle with specified change rate	ISO 16750-4-5.3 IEC 60068-2-14

